

PHD95N03LT

N-channel enhancement mode field-effect transistor

Rev. 01 — 18 July 2001

Product data

1. Description

N-channel logic level field-effect power transistor in a plastic package using TrenchMOS™¹ technology.

Product availability:

PHD95N03LT in SOT428 (D-PAK).

2. Features

- Low on-state resistance
- Fast switching.

3. Applications

- High frequency computer motherboard DC to DC converters

4. Pinning information

Table 1: Pinning - SOT428, simplified outline and symbol

| Pin | Description | Simplified outline | Symbol |
|-----|--|--|---------------|
| 1 | gate (g) | <p>Top view MBK091</p> <p>SOT428 (D-Pak)</p> | <p>MBB076</p> |
| 2 | drain (d) [1] | | |
| 3 | source (s) | | |
| mb | mounting base, connected to drain (d) | | |

[1] It is not possible to make connection to pin 2 of the SOT428 package.

1. TrenchMOS is a trademark of Royal Philips Electronics.



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5. Quick reference data

Table 2: Quick reference data

| Symbol | Parameter | Conditions | Typ | Max | Unit |
|------------|----------------------------------|----------------------------------|-----|-----|------|
| V_{DS} | drain-source voltage (DC) | $T_j = 25$ to 175 °C | – | 25 | V |
| I_D | drain current (DC) | $T_{mb} = 25$ °C; $V_{GS} = 5$ V | – | 75 | A |
| P_{tot} | total power dissipation | $T_{mb} = 25$ °C | – | 115 | W |
| T_j | junction temperature | | – | 175 | °C |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 10$ V; $I_D = 25$ A | 5 | 7 | mΩ |
| | | $V_{GS} = 5$ V; $I_D = 25$ A | 7.5 | 9 | mΩ |

6. Limiting values

Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

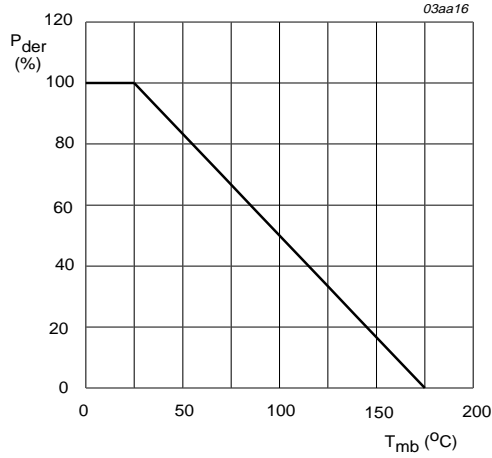
| Symbol | Parameter | Conditions | Min | Max | Unit |
|-----------|--------------------------------|---|-----|------|------|
| V_{DS} | drain-source voltage (DC) | $T_j = 25$ to 175 °C | – | 25 | V |
| V_{DGR} | drain-gate voltage (DC) | $T_j = 25$ to 175 °C; $R_{GS} = 20$ kΩ | – | 25 | V |
| V_{GS} | gate-source voltage (DC) | | – | ±15 | V |
| V_{GSM} | gate-source voltage | $t_p \leq 50$ μs; pulsed; duty cycle 25 %; $T_j \leq 150$ °C | – | ±20 | V |
| I_D | drain current (DC) | $T_{mb} = 25$ °C; $V_{GS} = 5$ V; Figure 2 and 3 | – | 75 | A |
| | | $T_{mb} = 100$ °C; $V_{GS} = 5$ V; Figure 2 | – | 61 | A |
| I_{DM} | peak drain current | $T_{mb} = 25$ °C; pulsed; $t_p \leq 10$ μs; Figure 3 | – | 240 | A |
| P_{tot} | total power dissipation | $T_{mb} = 25$ °C; Figure 1 | – | 115 | W |
| T_{stg} | storage temperature | | –55 | +175 | °C |
| T_j | operating junction temperature | | –55 | +175 | °C |

Source-drain diode

| | | | | | |
|----------|-------------------------------------|--|---|-----|---|
| I_S | source (diode forward) current (DC) | $T_{mb} = 25$ °C | – | 75 | A |
| I_{SM} | peak source (diode forward) current | $T_{mb} = 25$ °C; pulsed; $t_p \leq 10$ μs | – | 240 | A |

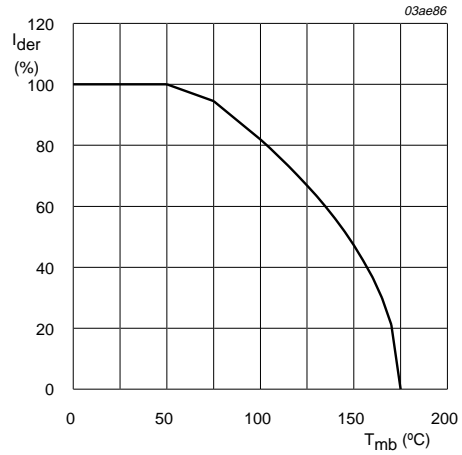
Avalanche ruggedness

| | | | | | |
|----------|----------------------------------|---|---|-----|----|
| E_{AS} | non-repetitive avalanche energy | unclamped inductive load; $I_D = 75$ A; $t_p = 0.1$ ms; $V_{DD} = 15$ V; $R_{GS} = 50$ Ω; $V_{GS} = 5$ V; starting $T_j = 25$ °C; | – | 120 | mJ |
| I_{AS} | non-repetitive avalanche current | unclamped inductive load; $V_{DD} = 15$ V; $R_{GS} = 50$ Ω; $V_{GS} = 5$ V; starting $T_j = 25$ °C | – | 75 | A |



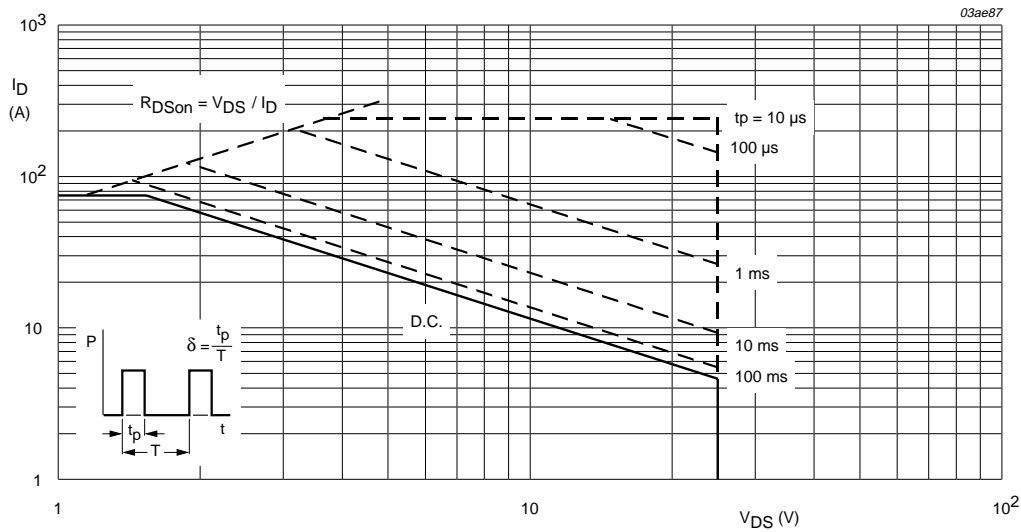
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature.



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature.



T_{mb} = 25 °C; I_{DM} is single pulse.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

7. Thermal characteristics

Table 4: Thermal characteristics

| Symbol | Parameter | Conditions | Value | Unit |
|----------------|---|---|-------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | Figure 4 | 1.3 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | mounted on a printed circuit board; minimum footprint | 50 | K/W |

7.1 Transient thermal impedance

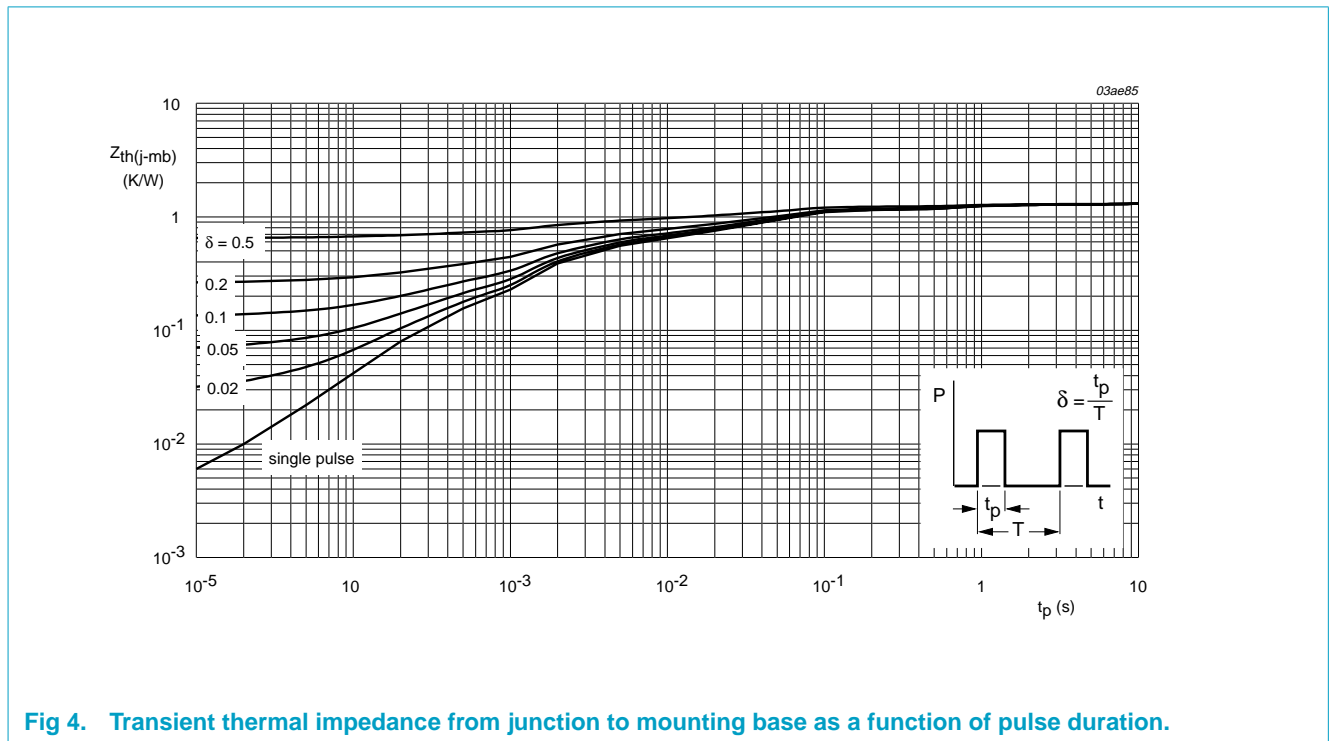
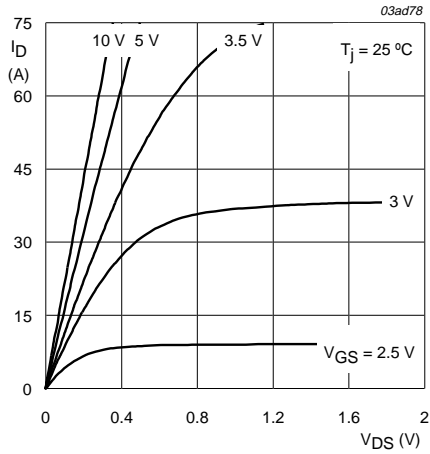


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

8. Characteristics

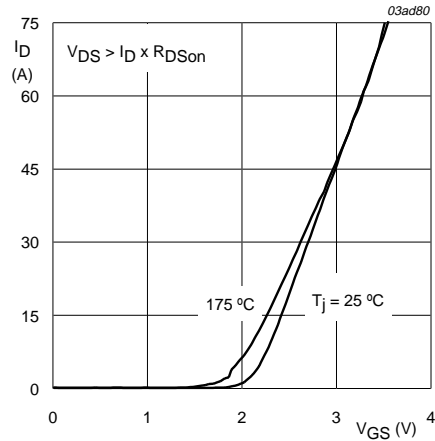
Table 5: Characteristics
 $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--------------------------------|--------------------------------------|---|-----|------|------|------------------|
| Static characteristics | | | | | | |
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $I_D = 0.25\text{ mA}$; $V_{GS} = 0\text{ V}$ $T_j = 25\text{ }^\circ\text{C}$ | 25 | – | – | V |
| | | $T_j = -55\text{ }^\circ\text{C}$ | 22 | – | – | V |
| $V_{GS(th)}$ | gate-source threshold voltage | $I_D = 1\text{ mA}$; $V_{DS} = V_{GS}$; Figure 9 $T_j = 25\text{ }^\circ\text{C}$ | 1 | 1.5 | 2 | V |
| | | $T_j = 175\text{ }^\circ\text{C}$ | 0.5 | – | – | V |
| | | $T_j = -55\text{ }^\circ\text{C}$ | – | – | 2.3 | V |
| I_{DSS} | drain-source leakage current | $V_{DS} = 25\text{ V}$; $V_{GS} = 0\text{ V}$ $T_j = 25\text{ }^\circ\text{C}$ | – | 0.05 | 10 | μA |
| | | $T_j = 175\text{ }^\circ\text{C}$ | – | – | 500 | μA |
| I_{GSS} | gate-source leakage current | $V_{GS} = \pm 5\text{ V}$; $V_{DS} = 0\text{ V}$ | – | 10 | 100 | nA |
| $R_{DS(on)}$ | drain-source on-state resistance | $V_{GS} = 5\text{ V}$; $I_D = 25\text{ A}$; Figure 7 and 8 $T_j = 25\text{ }^\circ\text{C}$ | – | 7.5 | 9 | $\text{m}\Omega$ |
| | | $T_j = 175\text{ }^\circ\text{C}$ | – | 13 | 15.5 | $\text{m}\Omega$ |
| | | $V_{GS} = 10\text{ V}$; $I_D = 25\text{ A}$; Figure 7 and 8 $T_j = 25\text{ }^\circ\text{C}$ | – | 5 | 7 | $\text{m}\Omega$ |
| Dynamic characteristics | | | | | | |
| g_{fs} | forward transconductance | $V_{DS} = 25\text{ V}$; $I_D = 50\text{ A}$ | – | 50 | – | S |
| $Q_{g(tot)}$ | total gate charge | $I_D = 50\text{ A}$; $V_{DD} = 12\text{ V}$; $V_{GS} = 4.5\text{ V}$; Figure 13 | – | 43 | – | nC |
| Q_{gs} | gate-source charge | | – | 12 | – | nC |
| Q_{gd} | gate-drain (Miller) charge | | – | 16 | – | nC |
| C_{iss} | input capacitance | $V_{GS} = 0\text{ V}$; $V_{DS} = 25\text{ V}$; $f = 1\text{ MHz}$; Figure 11 | – | 2200 | – | pF |
| C_{oss} | output capacitance | | – | 770 | – | pF |
| C_{rss} | reverse transfer capacitance | | – | 500 | – | pF |
| $t_{d(on)}$ | turn-on delay time | $V_{DD} = 15\text{ V}$; $I_D = 15\text{ A}$; $V_{GS} = 10\text{ V}$; $R_G = 6\text{ }\Omega$; resistive load | – | 10 | 20 | ns |
| t_r | turn-on rise time | | – | 30 | 50 | ns |
| $t_{d(off)}$ | turn-off delay time | | – | 110 | 140 | ns |
| t_f | turn-off fall time | | – | 80 | 100 | ns |
| Source-drain diode | | | | | | |
| V_{SD} | source-drain (diode forward) voltage | $I_S = 25\text{ A}$; $V_{GS} = 0\text{ V}$; Figure 12 | – | 0.85 | 1.2 | V |
| | | $I_S = 40\text{ A}$; $V_{GS} = 0\text{ V}$; Figure 12 | – | 0.9 | – | V |



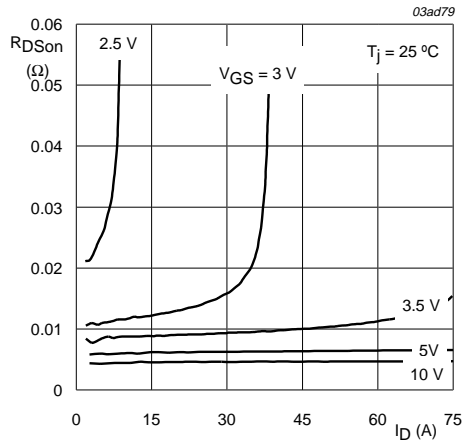
$T_j = 25\text{ }^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



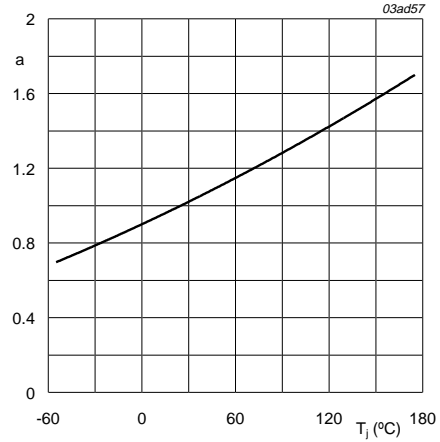
$T_j = 25\text{ }^\circ\text{C}$ and $175\text{ }^\circ\text{C}$; $V_{DS} \geq I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



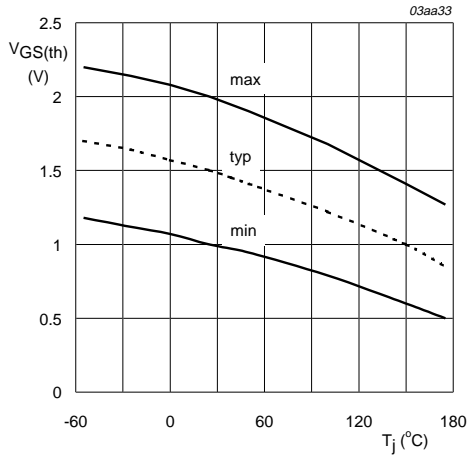
$T_j = 25\text{ }^\circ\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



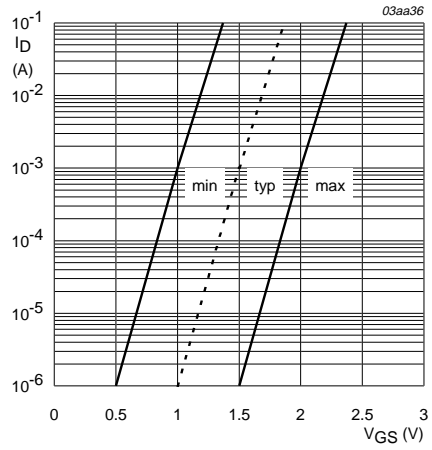
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



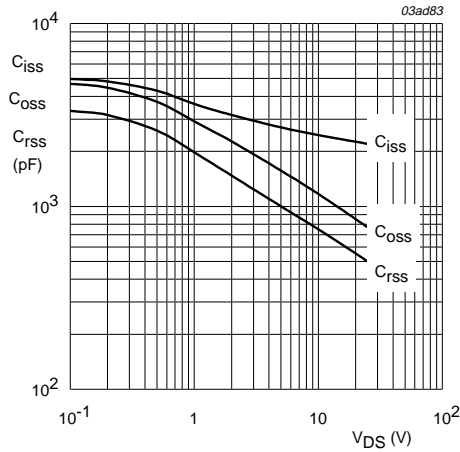
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature.



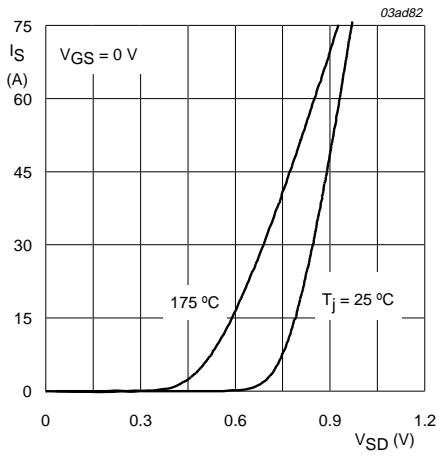
$T_j = 25 \text{ °C}; V_{DS} = 5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



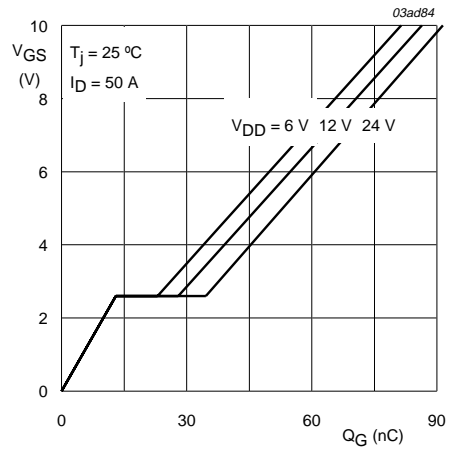
$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



$T_j = 25\text{ °C}$ and 175 °C ; $V_{GS} = 0\text{ V}$

Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



$I_D = 50\text{ A}$; $V_{DD} = 24\text{ V}$, 12 V and 6 V

Fig 13. Gate-source voltage as a function of gate charge; typical values.

9. Package outline

Plastic single-ended surface mounted package (Philips version of D-PAK); 3 leads
(one lead cropped)

SOT428

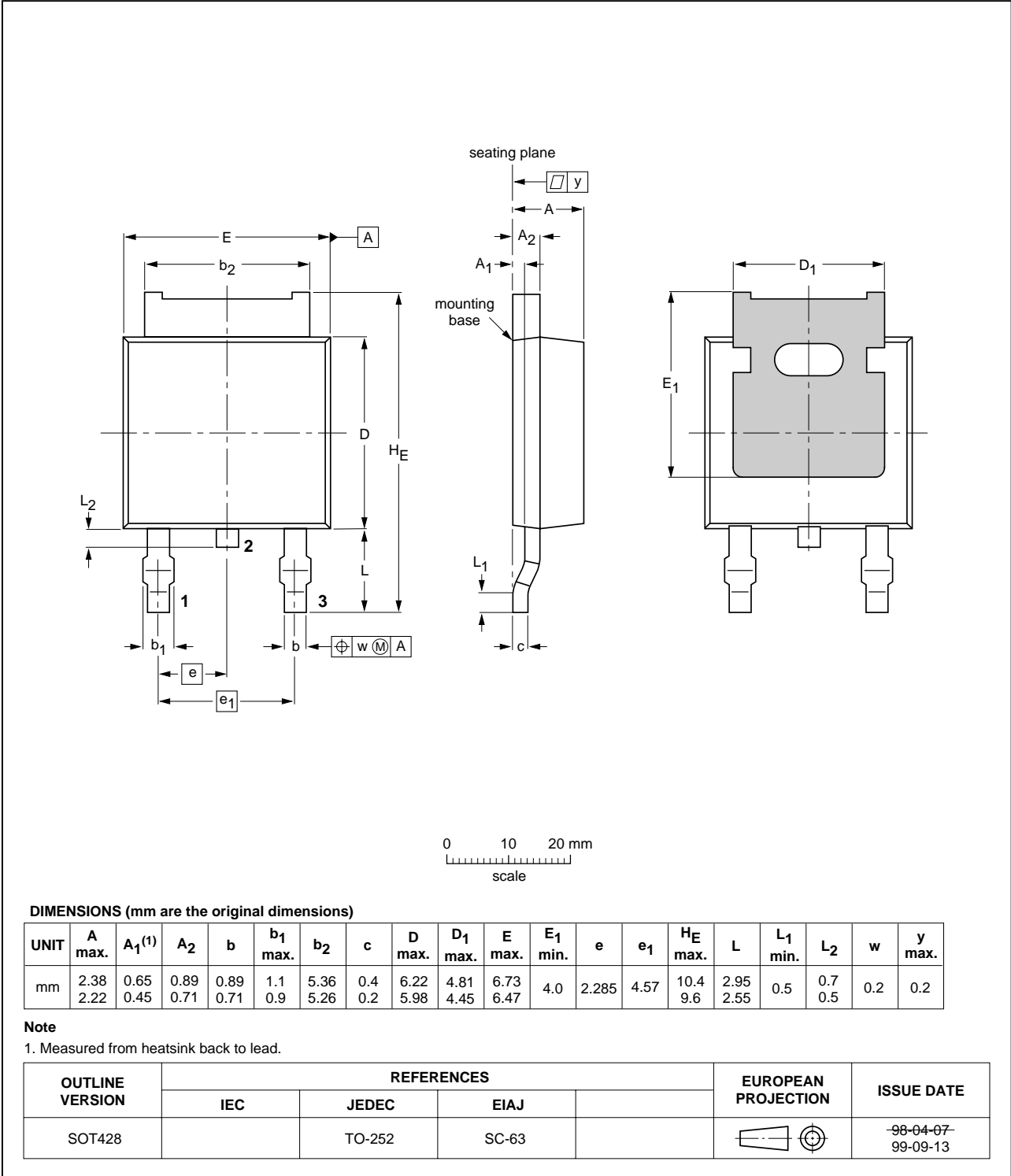


Fig 14. SOT428 (D-PAK).

10. Revision history

Table 6: Revision history

| Rev | Date | CPCN | Description |
|-----|----------|------|-------------------------------|
| 01 | 20010718 | - | Product data; initial version |

11. Data sheet status

| Data sheet status ^[1] | Product status ^[2] | Definition |
|----------------------------------|-------------------------------|--|
| Objective data | Development | This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice. |
| Preliminary data | Qualification | This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product. |
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[1] Please consult the most recently issued data sheet before initiating or completing a design.

[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

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